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Jia Cai Nie; Yamasaki, H.; Nakagawa, Y.; Develos-Bagarinao, K.; Murugesan, M.; Obara, H.; Mawatari, Y.;
[Applied Superconductivity, IEEE Transactions on](#)
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[AbstractPlus](#) | [References](#) | Full Text: [PDF](#)(784 KB) IEEE JNL
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- ☐ 2. **Thin film effects in the ferroelectric PbTiO₃**
Wasa, K.; Ai, R.; Ichikawa, Y.; Schlom, D.G.; Trolrier-McKinstry, S.; Qing Gang; Chang-Beom Eom;
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- ☐ 3. **Single domain/single crystal ferroelectric PbTiO₃ thin films**
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- ☐ 4. **Domain structure of PbTiO₃ films grown on vicinal (001) SrTiO₃**
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- ☐ 5. **AFM study of surface topography of InP epilayers: effect of miscut angle and growth temperature during MOVPE**
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6. Enhancement of coercive force in NiFe/FeRh-Ir bilayers grown on vicinal MgO(001) surfaces

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